

Silicon N Channel MOS Type (U-MOS II) / Silicon Epitaxial Schottky Barrier Diode

Preliminary

# TPCP8AA1

## ○ DC-DC Converter

- Combined Nch MOSFET and Schottky Diode into one Package.
- Low  $R_{DS(ON)}$  and Low  $V_F$

### Maximum Ratings (Ta = 25°C) MOSFET

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		$V_{DS}$	20	V
Gate-Source voltage		$V_{GSS}$	±12	V
Drain current	DC	$I_D$	1.6	A
	Pulse	$I_{DP}$ (Note 2)	3.2	
Drain power dissipation		$P_D$ (Note 1)	1.0	W
Channel temperature		$T_{ch}$	150	°C

### Maximum Ratings (Ta = 25°C) SCHOTTKY DIODE

Characteristics	Symbol	Rating	Unit
Maximum (peak) reverse voltage	$V_{RM}$	30	V
Reverse voltage	$V_R$	25	V
Average forward current	$I_O$	0.7	A
Peak one cycle surge forward current (non-repetitive)	$I_{FSM}$	4 (50 Hz)	A
Junction temperature	$T_j$	125	°C

### Maximum Ratings (Ta = 25°C) MOSFET, DIODE COMMON

Characteristics	Symbol	Rating	Unit
Storage temperature	$T_{stg}$	-55~125	°C
Operating temperature	$T_{opr}$ (Note 3)	-40~100	°C

Note 1: Mounted on FR4 board  
(25.4 mm × 25.4 mm × 1.6 t, Cu pad: 645 mm<sup>2</sup>)

Note 2: The pulse width limited by max channel temperature.

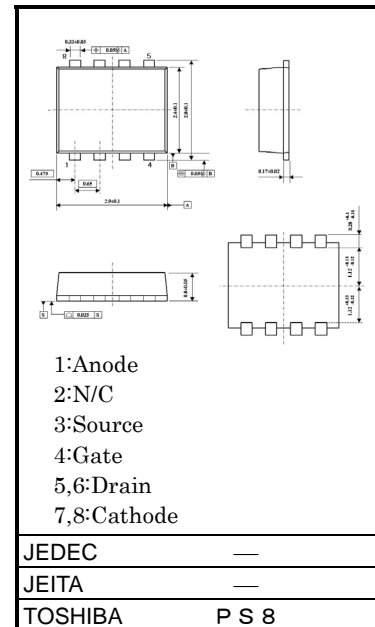
Note 3: Operating temperature limited by max channel temperature and max junction temperature.

### Handling Precaution

When handling individual devices (which are not yet mounting on a circuit board), be sure that the environment is protected against electrostatic discharge. Operators should wear anti-static clothing and use containers and other objects that are made of anti-static materials.

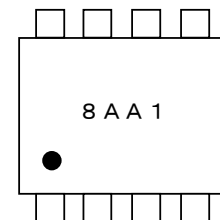
The Channel-to-Ambient thermal resistance  $R_{th(ch-a)}$  and the drain power dissipation  $P_D$  vary according to the board material, board area, board thickness and pad area. When using this device, please take heat dissipation fully into account.

単位: mm

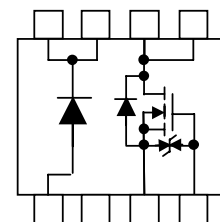


Weight: mg (typ)

### Making



### Equivalent



## MOSFET

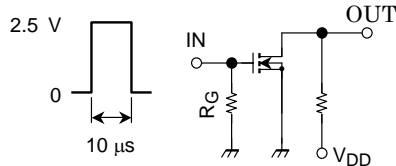
### Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	$I_{GSS}$	$V_{GS} = \pm 12\text{ V}, V_{DS} = 0$	—	—	$\pm 1$	$\mu\text{A}$
Drain-Source breakdown voltage	$V_{(BR) DSS}$	$I_D = 1\text{ mA}, V_{GS} = 0$	20	—	—	V
	$V_{(BR) DSX}$	$I_D = 1\text{ mA}, V_{GS} = -12\text{ V}$	12	—	—	
Drain Cut-off current	$I_{DSS}$	$V_{DS} = 20\text{ V}, V_{GS} = 0$	—	—	1	$\mu\text{A}$
Gate threshold voltage	$V_{th}$	$V_{DS} = 3\text{ V}, I_D = 0.1\text{ mA}$	0.5	—	1.2	V
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 3\text{ V}, I_D = 0.8\text{ A}$ (Note 4)	2.0	—	—	S
Drain-Source ON resistance	$R_{DS(ON)}$	$I_D = 0.8\text{ A}, V_{GS} = 4\text{ V}$ (Note 4)	—	77	105	m $\Omega$
		$I_D = 0.8\text{ A}, V_{GS} = 2.5\text{ V}$ (Note 4)	—	100	140	
		$I_D = 0.8\text{ A}, V_{GS} = 2.0\text{ V}$ (Note 4)	—	125	210	
Input capacitance	$C_{iss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$	—	306	—	pF
Reverse transfer capacitance	$C_{rss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$	—	44	—	pF
Output capacitance	$C_{oss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0, f = 1\text{ MHz}$	—	74	—	pF
Switching time	Turn-on time	$t_{on}$	$V_{DD} = 10\text{ V}, I_D = 0.8\text{ A}$		—	ns
	Turn-off time	$t_{off}$	$V_{GS} = 0\text{--}2.5\text{ V}, R_G = 4.7\ \Omega$		—	

Note 4: Pulse measurement

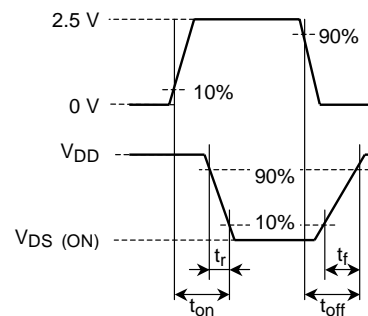
### Switching Time Test Circuit

#### (a) Test circuit

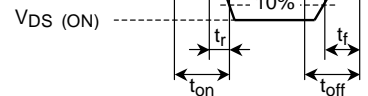


$V_{DD} = 10\text{ V}$   
 $R_G = 4.7\ \Omega$   
 Duty  $\leq 1\%$   
 IN:  $t_r, t_f < 5\text{ ns}$   
 Common Source  
 $T_a = 25^\circ\text{C}$

#### (b) $V_{IN}$



#### (c) $V_{out}$



### Precaution

$V_{th}$  can be expressed as voltage between gate and source when low operating current value is  $I_D = 100\ \mu\text{A}$  for this product. For normal switching operation,  $V_{GS(ON)}$  requires higher voltage than  $V_{th}$  and  $V_{GS(OFF)}$  requires lower voltage than  $V_{th}$ .

(Relationship can be established as follows:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ )

Please take this into consideration for using the device.

$V_{GS}$  recommended voltage of 2.5 V or higher to turn on this product.

**Schottky Diode****Electrical Characteristics (Ta = 25°C)**

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Forward voltage	$V_F (1)$	$I_F = 0.5 \text{ A}$	—	0.36	0.41	V
	$V_F (2)$	$I_F = 0.7 \text{ A}$	—	0.40	0.45	V
Reverse current	$I_R$	$V_R = 10 \text{ V}$	—	—	100	$\mu\text{A}$
Total capacitance	$C_T$	$V_R = 10 \text{ V}, f = 1 \text{ MHz}$	—	20	—	pF

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